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PTO/SB/21 (09-04) Approved for use through 07/31/2006. OMB 0651-0031

U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it displays a valid OMB control number. Application Number 10/772.434 Filing Date TRANSMITTAL February 6, 2004 First Named Inventor **FORM** Ramachandran KRISHNASWAMY Art Unit 2128 (to be used for all correspondence after initial filing) **Examiner Name** K. Shah Attorney Docket Number Total Number of Pages in This Submission 6 + 5 Refs 333772000800 ENCLOSURES (Check all that apply) After Allowance Communication Fee Transmittal Form Drawing(s) Appeal Communication to Board of Fee Attached Licensing-related Papers Appeals and Interferences Appeal Communication to TC Petition Amendment/Reply (Appeal Notice, Brief, Reply Brief) Petition to Convert to a After Final Proprietary Information **Provisional Application** Power of Attorney, Revocation Affidavits/declaration(s) Status Letter Change of Correspondence Address X Other Endow): Other Enclosure(s) (please Extension of Time Request Terminal Disclaimer Form PTO/SB/08a/b + duplicate **Express Abandonment Request** Request for Refund copy - 2 pages Information Disclosure Statement CD, Number of CD(s) Five (5) References (Supplemental) - 3 pages Certified Copy of Priority Return Receipt Postcard Landscape Table on CD Document(s) Reply to Missing Parts/ Remarks Incomplete Application Reply to Missing Parts under 37 CFR 1.52 or 1.53 SIGNATURE OF APPLICANT, ATTORNEY, OR AGENT Firm Name MORRISON & FOERSTER LLP (Customer No. 25226) Signature Printed name Thomas Chan

	e is being deposited with the U.S. Postal Service as Express Mail, Airbill No. EV 535603481 mendment, Commissionar for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on the
Dated: March 10, 2006	Signature: Roqua Mald, (Georgina Matos)

Reg. No.

51,543

Date

March 10, 2006

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MAR 2313-1450, on the date shown below.

Dated: March 10, 2006

Signature: Aux. March 10, 2006

Signature: Aux. March 10, 2006

Signature: Aux. March 10, 2006

PATENT Docket No. 333772000800

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of: Ramachandran KRISHNASWAMY et al.

Serial No.: 10/772,434

Filing Date: February 6, 2004

For: METHOD AND STRUCTURE TO

DEVELOP A TEST PROGRAM FOR SEMICONDUCTOR INTEGRATED

CIRCUITS

Examiner: K. Shah

Group Art Unit: 2128

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97 & 1.98

MS Amendment Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

Dear Sir:

Pursuant to 37 C.F.R. §1.97 and § 1.98, Applicants submit for consideration in the above-identified application the documents listed on the attached Form PTO/SB/08a/b. Copies of the foreign document and non-patent literature are submitted herewith. The Examiner is requested to make these documents of record.

pa-1034823

	This S	Supplemental Information Disclosure Statement is submitted:			
	With	the application; accordingly, no fee or separate requirements are required.			
	Before the mailing of a first Office Action after the filing of a Request for Continued				
	Exam	ination under § 1.114. However, if applicable, a certification under 37 C.F.R. § 1.97			
	(e)(1)	has been provided.			
\boxtimes	Withi	n three months of the application filing date or before mailing of a first Office Action			
	on the	e merits; accordingly, no fee or separate requirements are required. However, if			
	applic	cable, a certification under 37 C.F.R. § 1.97 (e)(1) has been provided.			
	After receipt of a first Office Action on the merits but before mailing of a final Office Action				
	or Notice of Allowance.				
		A fee is required. A check in the amount of is enclosed.			
		A fee is required. Accordingly, a Fee Transmittal form (PTO/SB/17) is attached to			
		this submission in duplicate.			
		A Certification under 37 C.F.R. § 1.97(e) is provided above; accordingly; no fee is			
		believed to be due.			
	After mailing of a final Office Action or Notice of Allowance, but before payment of the				
	issue	fee.			
		A Certification under 37 C.F.R. § 1.97(e) is provided above and a check in the			
		amount of is enclosed.			
		A Certification under 37 C.F.R. § 1.97(e) is provided above and a Fee Transmittal			
		form (PTO/SB/17 is attached to this submission in duplicate.)			

Applicants would appreciate the Examiner initialing and returning the Form PTO/SB/08a/b, indicating that the information has been considered and made of record herein.

The information contained in this Supplemental Information Disclosure Statement under 37 C.F.R. § 1.97 and § 1.98 is not to be construed as a representation that: (i) a complete search has been made; (ii) additional information material to the examination of this application does not exist;

PATENT Docket No. 333772000800

(iii) the information, protocols, results and the like reported by third parties are accurate or enabling; or (iv) the above information constitutes prior art to the subject invention.

In the unlikely event that the transmittal form is separated from this document and the Patent and Trademark Office determines that an extension and/or other relief (such as payment of a fee under 37 C.F.R. § 1.17 (p)) is required, Applicants petition for any required relief including extensions of time and authorize the Commissioner to charge the cost of such petition and/or other fees due in connection with the filing of this document to **Deposit Account No. 03-1952** referencing 333772000800.

Dated: March 10, 2006

Respectfully submitted,

Thomas Chan

Registration No.: 51,543

MORRISON & FOERSTER LLP

755 Page Mill Road

Palo Alto, California 94304-1018

(650) 813-5616



Substitute for form 1449/PTO

Sheet

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

1 of 1

Complete if Known			
Application Number	10/772,434		
Filing Date	February 6, 2004		
First Named Inventor	Ramachandran KRISHNASWAMY		
Art Unit	2128		
Examiner Name	Not Yet Assigned		
Attorney Docket Number	333772000800		

U.S. PATENT DOCUMENTS						
Examiner Initials*			Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
	1.	US-2003/0217343-A1	11-20-2003	Rajsuman et al.		
				Comfort et al.		

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No.1	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (ff known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	 T ⁴
	3.	DE-10031536-A1	01-18-2001	Advantest Corp.	Translation of Abstract Only	

*EXAMINER: Initial if information considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. Applicant's unique citation designation number (optional). See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. Applicant is to place a check mark here if English language Translation is attached.

	NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No. 1 Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (bi magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, ci and/or country where published.					
	4.	International Search Report mailed on February 16, 2006 for PCT Application No. PCT/JP2005/009813 filed on May 23, 2005, 5 pages.				
	5.	Portelli, B. et al. (May 22, 1989). "Demonstration of Avionics Module Exchangeability via Simulation (DAMES) Program Overview," <i>Proceedings of the IEEE 1989 Natl Aerospace and Flect. Conf. (NAECON 1989)</i> . Dayton, OH, vol. 2:660-667.				
	6.	Rajsuman, R. (Jan. 30, 2004). "An Overview of the Open Architecture Test System," Proceedings of the 2nd IEEE Intl Workshop on Elect. Design, Test, and Applications (Delta'04). pp. 1-6.				
	7.	Semiconductor Test Consortium. "ATE Open Architecture Initiative," (October 8, 2002). located at http://www.semitest.org/site/News/News_Files/file_news2 last visited on March 8, 2006, 12 pages.				

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Examiner	Date	
Signature	Considered	
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¹Applicant's unique citation designation number (optional). ²Applicant is to place a check mark here if English language Translation is attached.